



FGPF70N33BT

330V, 70A PDP IGBT

Features

- High current capability
- Low saturation voltage: $V_{CE(sat)}=1.7V @ I_C = 70A$
- High input impedance
- Fast switching
- RoHS Compliant

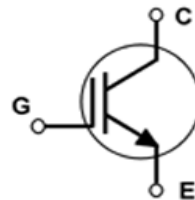
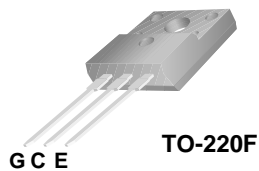
Applications

- PDP System



General Description

Using Novel Trench IGBT Technology, Fairchild's new series of trench IGBTs offer the optimum performance for PDP applications where low conduction and switching losses are essential.



Absolute Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted

| Symbol | Description | Ratings | Units |
|--------------------|---|-------------|------------|
| V_{CES} | Collector to Emitter Voltage | 330 | V |
| V_{GES} | Gate to Emitter Voltage | ± 30 | V |
| $I_{Cpulse(1)*}$ | Pulsed Collector Current @ $T_C = 25^\circ C$ | 160 | A |
| $I_{C\ pulse(2)*}$ | Pulsed Collector Current @ $T_C = 25^\circ C$ | 220 | A |
| P_D | Maximum Power Dissipation @ $T_C = 25^\circ C$ | 48 | W |
| | Maximum Power Dissipation @ $T_C = 100^\circ C$ | 19 | W |
| T_J, T_{stg} | Operating Junction Temperature and Storage Temperature | -55 to +150 | $^\circ C$ |
| T_L | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds | 300 | $^\circ C$ |

Thermal Characteristics

| Symbol | Parameter | Typ. | Max. | Units |
|-----------------------|---|------|------|--------------|
| $R_{\theta JC}(IGBT)$ | Thermal Resistance, Junction to Case | -- | 2.62 | $^\circ C/W$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | -- | 40 | $^\circ C/W$ |

Notes:

- 1: Repetitive test , Pulse width=100usec , Duty=0.1
 - 2: Half Sine Wave, $D < 0.01$, pluse width < 5usec
- * I_{C_pulse} limited by max T_J

Package Marking and Ordering Information

| Device Marking | Device | Package | Packaging Type | Qty per Tube | Max Qty per Box |
|----------------|---------------|---------|----------------|--------------|-----------------|
| FGPF70N33BT | FGPF70N33BTTU | TO-220F | Tube | 50ea | -- |

Electrical Characteristics of the IGBT T_C = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|-------------------------------------|--|--|------|------|-----------|---------|
| Off Characteristics | | | | | | |
| V_{CES} | Collector to Emitter Breakdown Voltage | $V_{GE} = 0V, I_C = 250\mu A$ | 330 | -- | -- | V |
| $\frac{\Delta V_{CES}}{\Delta T_J}$ | Temperature Coefficient of Breakdown Voltage | $V_{GE} = 0V, I_C = 250\mu A$ | -- | 0.3 | -- | V/°C |
| I_{CES} | Collector Cut-Off Current | $V_{CE} = V_{CES}, V_{GE} = 0V$ | -- | -- | 250 | μA |
| I_{GES} | G-E Leakage Current | $V_{GE} = V_{GES}, V_{CE} = 0V$ | -- | -- | ± 400 | nA |
| On Characteristics | | | | | | |
| $V_{GE(th)}$ | G-E Threshold Voltage | $I_C = 250\mu A, V_{CE} = V_{GE}$ | 2.3 | 3.3 | 4.3 | V |
| $V_{CE(sat)}$ | Collector to Emitter Saturation Voltage | $I_C = 20A, V_{GE} = 15V$ | -- | 1.1 | -- | V |
| | | $I_C = 40A, V_{GE} = 15V,$ | -- | 1.4 | -- | V |
| | | $I_C = 70A, V_{GE} = 15V, T_C = 25^\circ C$ | -- | 1.7 | -- | V |
| | | $I_C = 70A, V_{GE} = 15V, T_C = 125^\circ C$ | -- | 1.8 | -- | V |
| Dynamic Characteristics | | | | | | |
| C_{ies} | Input Capacitance | $V_{CE} = 30V, V_{GE} = 0V, f = 1MHz$ | -- | 1380 | -- | pF |
| C_{oes} | Output Capacitance | | -- | 140 | -- | pF |
| C_{res} | Reverse Transfer Capacitance | | -- | 60 | -- | pF |
| Switching Characteristics | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{CC} = 200V, I_C = 20A, R_G = 5\Omega, V_{GE} = 15V, Resistive Load, T_C = 25^\circ C$ | -- | 13 | -- | ns |
| t_r | Rise Time | | -- | 26 | -- | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | -- | 46 | -- | ns |
| t_f | Fall Time | | -- | 198 | -- | ns |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{CC} = 200V, I_C = 20A, R_G = 5\Omega, V_{GE} = 15V, Resistive Load, T_C = 125^\circ C$ | -- | 13 | -- | ns |
| t_r | Rise Time | | -- | 28 | -- | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | -- | 48 | -- | ns |
| t_f | Fall Time | | -- | 268 | -- | ns |
| Q_g | Total Gate Charge | $V_{CE} = 200V, I_C = 20A, V_{GE} = 15V$ | -- | 49 | -- | nC |
| Q_{ge} | Gate to Emitter Charge | | -- | 6.8 | -- | nC |
| Q_{gc} | Gate to Collector Charge | | -- | 17.5 | -- | nC |

Typical Performance Characteristics

Figure 1. Typical Output Characteristics

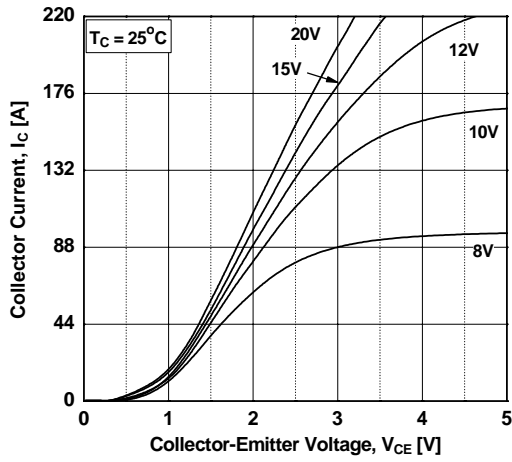


Figure 2. Typical Output Characteristics

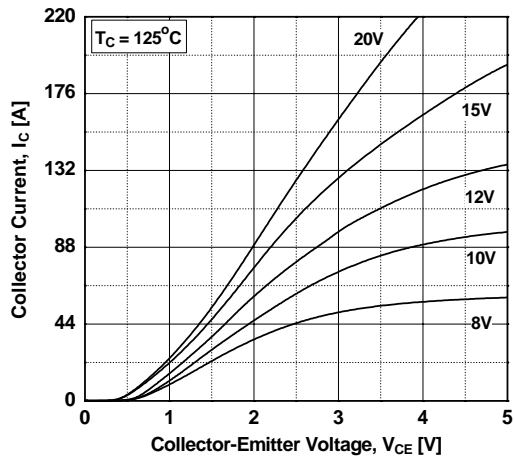


Figure 3. Typical Saturation Voltage Characteristics

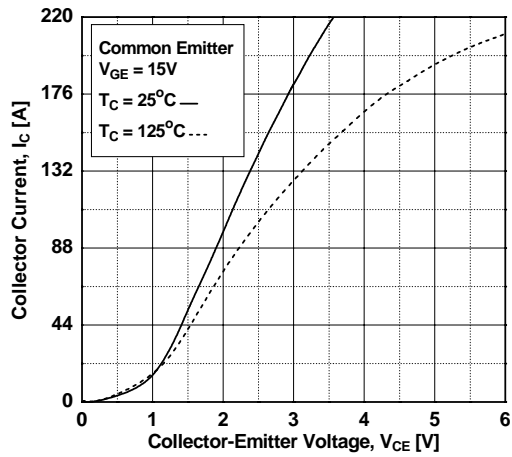


Figure 4. Transfer Characteristics

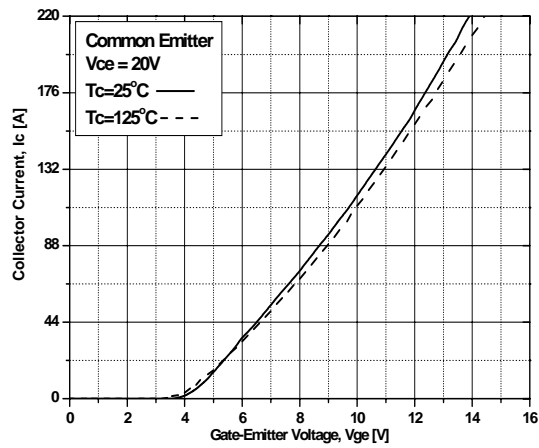


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level

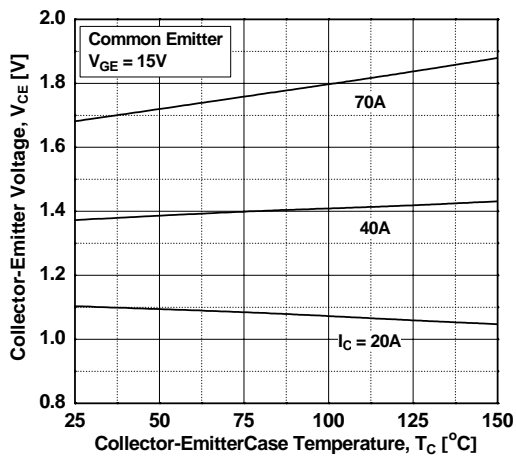
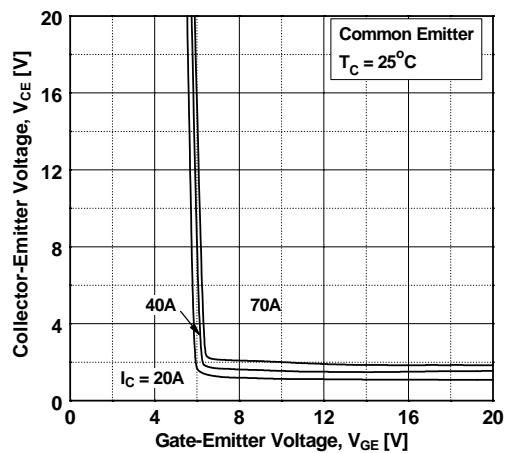


Figure 6. Saturation Voltage vs. Vge



Typical Performance Characteristics

Figure 7. Saturation Voltage vs. V_{GE}

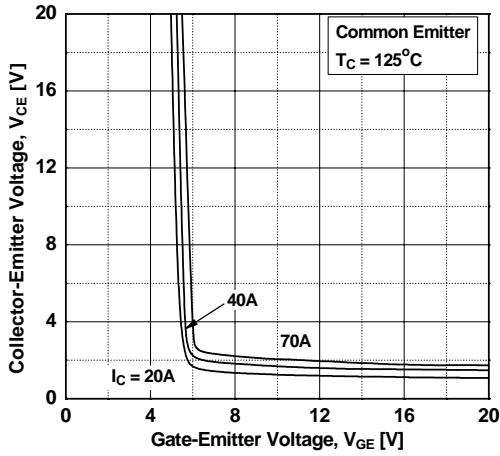


Figure 8. Capacitance Characteristics

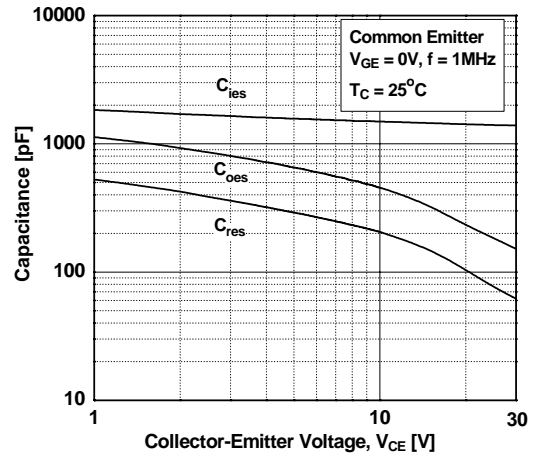


Figure 9. Gate charge Characteristics

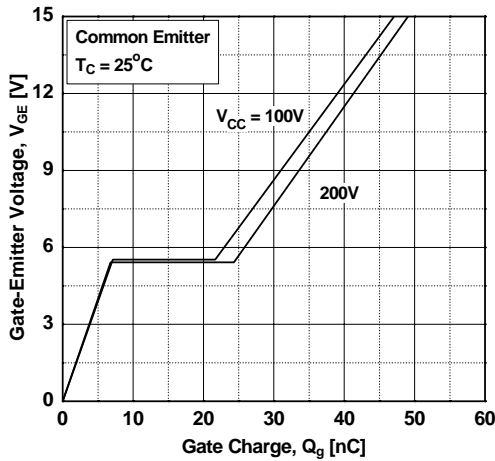


Figure 10. SOA Characteristics

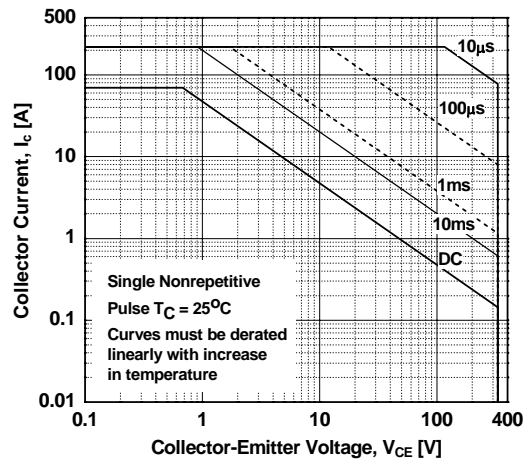


Figure 11. Turn-on Characteristics vs. Gate Resistance

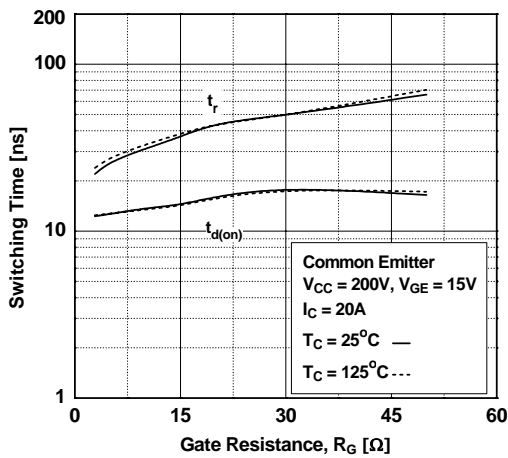
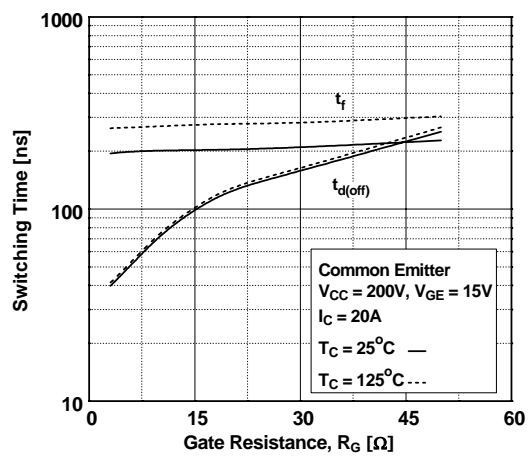


Figure 12. Turn-off Characteristics vs. Gate Resistance



Typical Performance Characteristics

Figure 13. Turn-on Characteristics vs. Collector Current

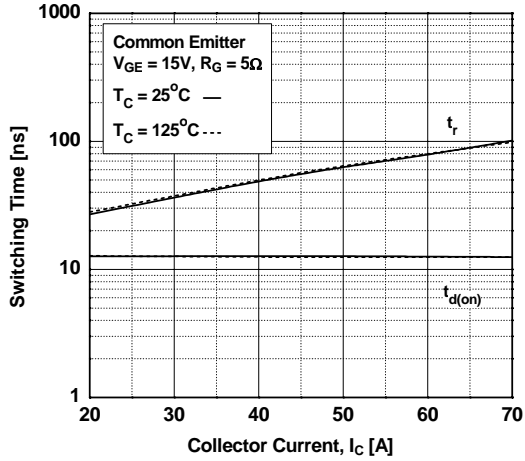


Figure 14. Turn-off Characteristics vs. Collector Current

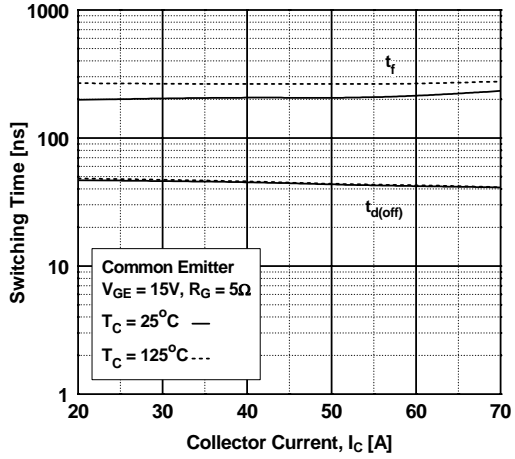


Figure 15. Switching Loss vs. Gate Resistance

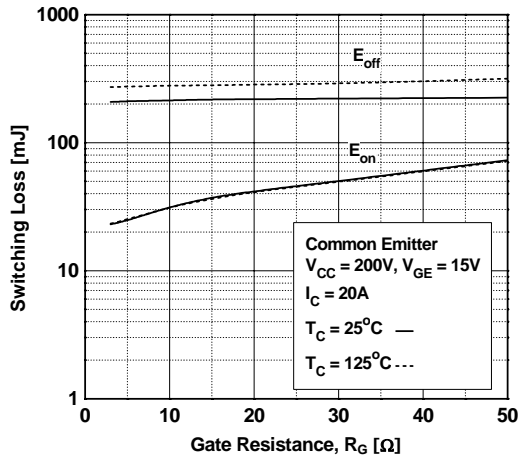


Figure 16. Switching Loss vs. Collector Current

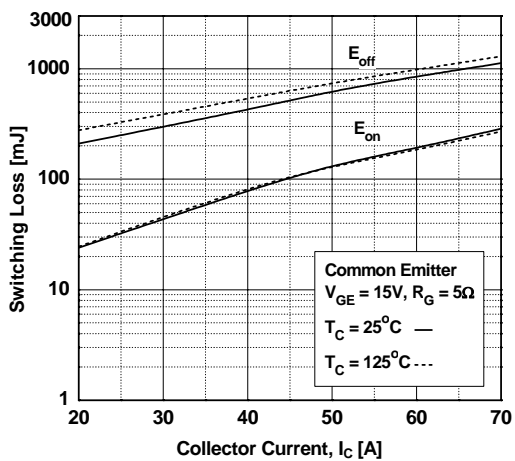
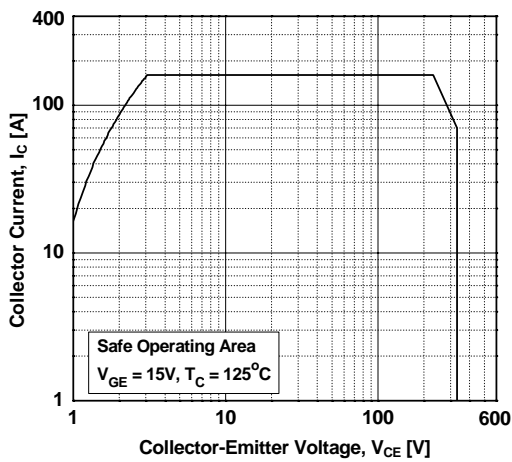
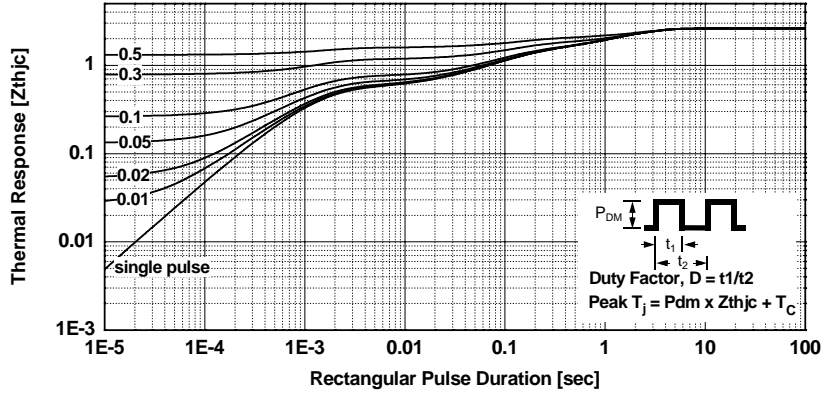


Figure 17. Turn off Switching SOA Characteristics



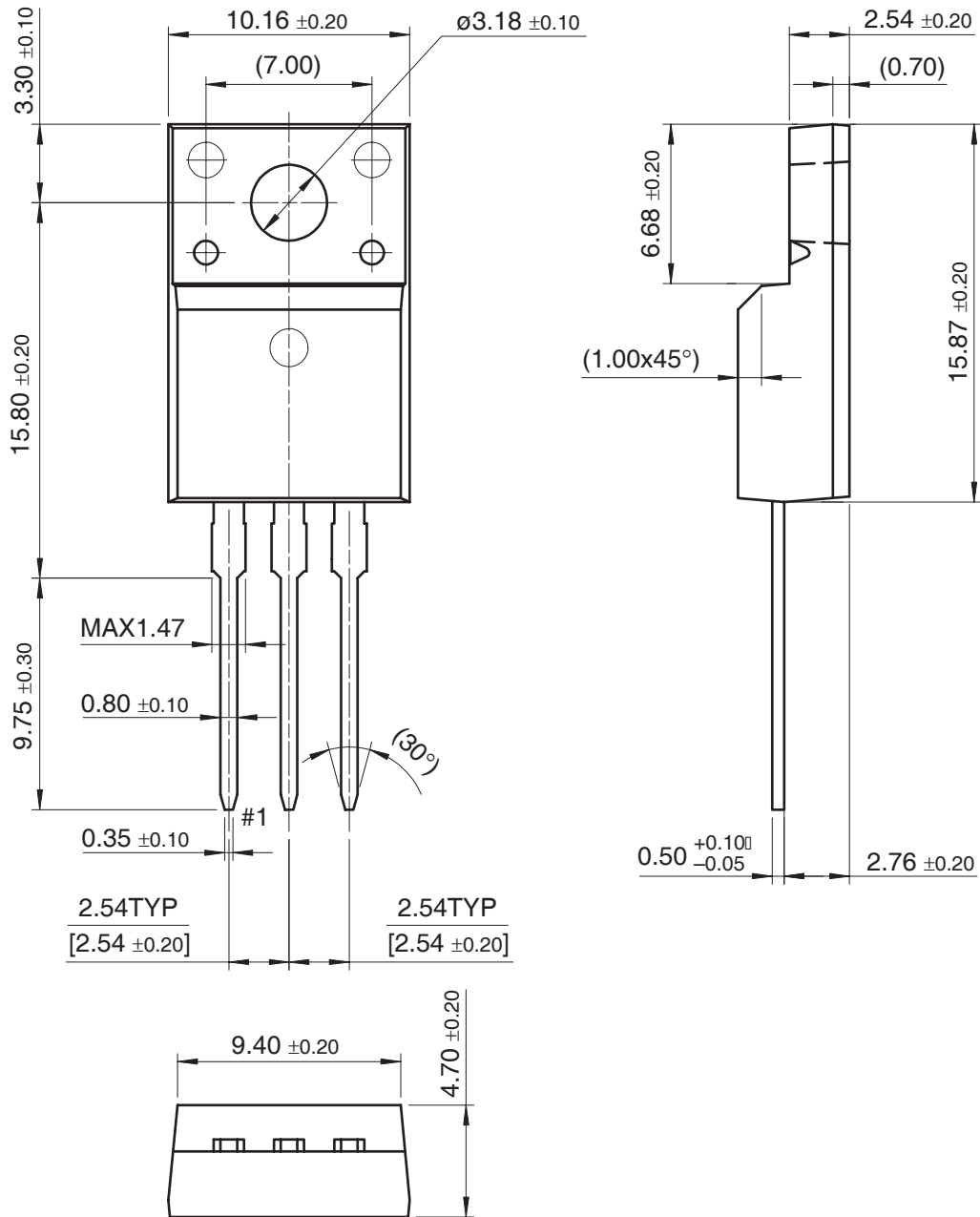
Typical Performance Characteristics

Figure 18. Transient Thermal Impedance of IGBT



Mechanical Dimensions

TO-220F






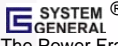


Dimensions in Millimeters



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